

Notice of References Cited	Application/Control No. 10/669,632	Applicant(s)/Patent Under Reexamination FUJITA ET AL.	
	Examiner Hoan H. Tran	Art Unit 2852	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,600,884	07-2003	Shimmura, Shoko	399/57
	C	US-5,787,320	07-1998	Eun et al.	399/59
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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